

# BLF7G21L-160P; BLF7G21LS-160P

Power LDMOS transistor

Rev. 3 — 10 February 2014

Product data sheet

## 1. Product profile

### 1.1 General description

160 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2050 MHz, also suitable for operation at 1495 MHz to 1511 MHz.

**Table 1. Typical performance**

Typical RF performance at  $T_{case} = 25\text{ °C}$  in a common source class-AB production test circuit.

| Mode of operation | f<br>(MHz)   | $I_{DQ}$<br>(mA) | $V_{DS}$<br>(V) | $P_{L(AV)}$<br>(W) | $G_p$<br>(dB) | $\eta_D$<br>(%) | ACPR<br>(dBc)           |
|-------------------|--------------|------------------|-----------------|--------------------|---------------|-----------------|-------------------------|
| 2-carrier W-CDMA  | 1930 to 1990 | 1080             | 28              | 45                 | 18            | 34              | -30 <a href="#">[1]</a> |
| 1-carrier W-CDMA  | 1930 to 1990 | 1080             | 28              | 50                 | 18.0          | 36              | -34 <a href="#">[2]</a> |

[1] Test signal: 3GPP; test model 1; 64 DPCH; PAR = 8.4 dB at 0.01 % probability on CCDF; carrier spacing 5 MHz.

[2] Test signal: 3GPP; test model 1; 64 DPCH; PAR = 7.2 dB at 0.01 % probability on CCDF.

### 1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low thermal resistance providing excellent thermal stability
- Designed for broadband operation (1800 MHz to 2050 MHz)
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent pre-distortability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

### 1.3 Applications

- RF power amplifiers for base stations and multi carrier applications in the 1800 MHz to 2050 MHz frequency range



## 2. Pinning information

Table 2. Pinning

| Pin                              | Description | Simplified outline | Graphic symbol                           |
|----------------------------------|-------------|--------------------|--|
| <b>BLF7G21L-160P (SOT1121A)</b>  |             |                    |  |
| 1                                | drain1      |                    | <p style="text-align: right;">sym117</p> |
| 2                                | drain2      |                    |  |
| 3                                | gate1       |                    |  |
| 4                                | gate2       |                    |  |
| 5                                | source      |                    |  |
| <b>BLF7G21LS-160P (SOT1121B)</b> |             |                    |  |
| 1                                | drain1      |                    | <p style="text-align: right;">sym117</p> |
| 2                                | drain2      |                    |  |
| 3                                | gate1       |                    |  |
| 4                                | gate2       |                    |  |
| 5                                | source      |                    |  |

[1] Connected to flange.

## 3. Ordering information

Table 3. Ordering information

| Type number    | Package |   |          |
|----------------|---------|---|----------|
|                | Name    | Description   | Version  |
| BLF7G21L-160P  | -       | flanged LDMOST ceramic package; 2 mounting holes; 4 leads | SOT1121A |
| BLF7G21LS-160P | -       | earless flanged ceramic package; 4 leads                  | SOT1121B |

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol    | Parameter            | Conditions | Min  | Max  | Unit |
|-----------|----------------------|------------|------|------|------|
| $V_{DS}$  | drain-source voltage |            | -    | 65   | V    |
| $V_{GS}$  | gate-source voltage  |            | -0.5 | +13  | V    |
| $I_D$     | drain current        |            | -    | 32.5 | A    |
| $T_{stg}$ | storage temperature  |            | -65  | +150 | °C   |
| $T_j$     | junction temperature |            | -    | 200  | °C   |

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

| Symbol        | Parameter                                | Conditions                                    | Typ  | Unit |
|---------------|--|---|------|------|
| $R_{th(j-c)}$ | thermal resistance from junction to case | $T_{case} = 80\text{ °C}; P_L = 100\text{ W}$ | 0.41 | K/W  |

## 6. Characteristics

**Table 6. Characteristics**

$T_j = 25\text{ °C}$ ; per section unless otherwise specified.

| Symbol        | Parameter                        | Conditions  | Min | Typ  | Max | Unit          |
|---------------|----------------------------------|---|-----|------|-----|---------------|
| $V_{(BR)DSS}$ | drain-source breakdown voltage   | $V_{GS} = 0\text{ V}; I_D = 0.9\text{ mA}$                  | 65  | -    | -   | V             |
| $V_{GS(th)}$  | gate-source threshold voltage    | $V_{DS} = 10\text{ V}; I_D = 90\text{ mA}$                  | 1.5 | 1.9  | 2.3 | V             |
| $I_{DSS}$     | drain leakage current            | $V_{GS} = 0\text{ V}; V_{DS} = 28\text{ V}$                 | -   | -    | 2   | $\mu\text{A}$ |
| $I_{DSX}$     | drain cut-off current            | $V_{GS} = V_{GS(th)} + 3.75\text{ V}; V_{DS} = 10\text{ V}$ | 14  | -    | -   | A             |
| $I_{GSS}$     | gate leakage current             | $V_{GS} = 11\text{ V}; V_{DS} = 0\text{ V}$                 | -   | -    | 200 | nA            |
| $g_{fs}$      | forward transconductance         | $V_{DS} = 10\text{ V}; I_D = 4.5\text{ A}$                  | -   | 7    | -   | S             |
| $R_{DS(on)}$  | drain-source on-state resistance | $V_{GS} = V_{GS(th)} + 3.75\text{ V}; I_D = 3.15\text{ A}$  | -   | 0.15 | -   | $\Omega$      |

## 7. Test information

**Table 7. Application information**

Mode of operation: 2-carrier W-CDMA; PAR 8.4 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 PDPCH;  $f_1 = 1932.5\text{ MHz}$ ;  $f_2 = 1937.5\text{ MHz}$ ;  $f_3 = 1982.5\text{ MHz}$ ;  $f_4 = 1987.5\text{ MHz}$ ; RF performance at  $V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 1080\text{ mA}$ ;  $T_{case} = 25\text{ °C}$ ; unless otherwise specified; in a class-AB production test circuit.

| Symbol       | Parameter                             | Conditions                | Min  | Typ  | Max | Unit |
|--------------|---------------------------------------|---------------------------|------|------|-----|------|
| $G_p$        | power gain                            | $P_{L(AV)} = 45\text{ W}$ | 17.0 | 18.0 | -   | dB   |
| $RL_{in}$    | input return loss                     | $P_{L(AV)} = 45\text{ W}$ | -    | -15  | -8  | dB   |
| $\eta_D$     | drain efficiency                      | $P_{L(AV)} = 45\text{ W}$ | 31   | 34   | -   | %    |
| $ACPR_{5M}$  | adjacent channel power ratio (5 MHz)  | $P_{L(AV)} = 45\text{ W}$ | -    | -30  | -25 | dBc  |
| $ACPR_{10M}$ | adjacent channel power ratio (10 MHz) | $P_{L(AV)} = 45\text{ W}$ | -    | -    | -   | dBc  |

**Table 8. Application information**

Mode of operation: 1-carrier W-CDMA; PAR 7.2 dB at 0.01 % probability on CCDF; 3GPP test model 1; 64 PDPCH;  $f_1 = 1932.5\text{ MHz}$ ;  $f_2 = 1987.5\text{ MHz}$ ; RF performance at  $V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 1080\text{ mA}$ ;  $T_{case} = 25\text{ °C}$ ; unless otherwise specified; in a class-AB production test circuit.

| Symbol  | Parameter                    | Conditions   | Min | Typ | Max | Unit |
|---------|------------------------------|--|-----|-----|-----|------|
| $PAR_O$ | output peak-to-average ratio | $P_{L(AV)} = 80\text{ W}$ ;<br>at 0.01 % probability on CCDF | 4.0 | 4.5 | -   | dB   |

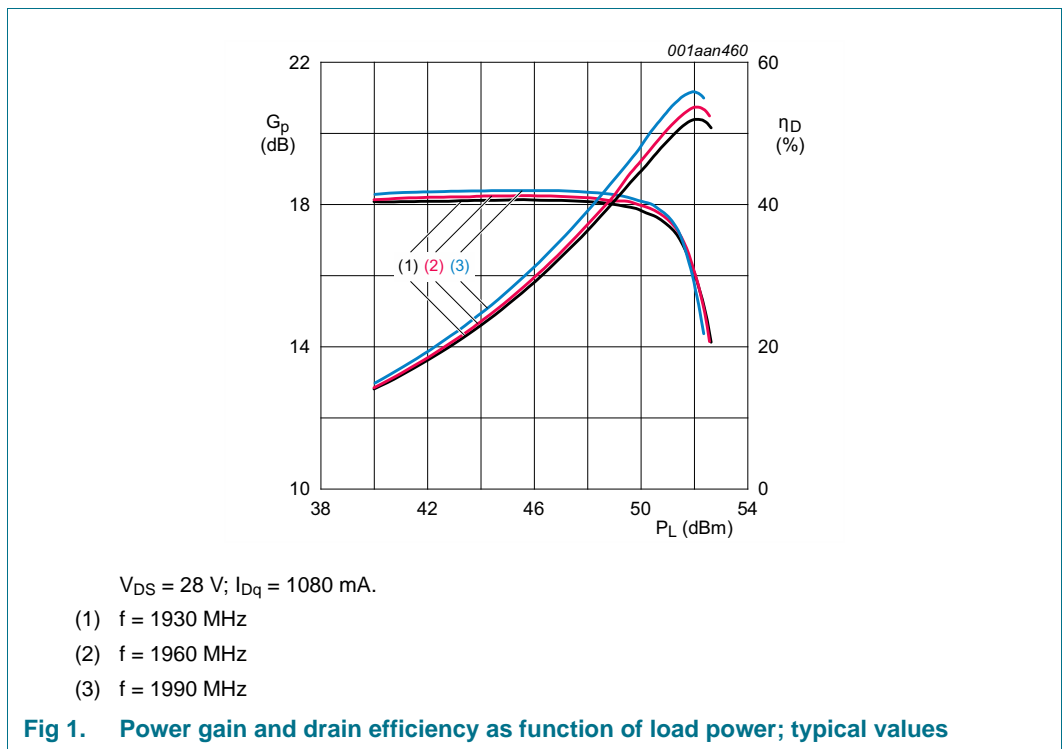
## 7.1 Ruggedness in class-AB operation

The BLF7G21L-160P and BLF7G21LS-160P are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions:

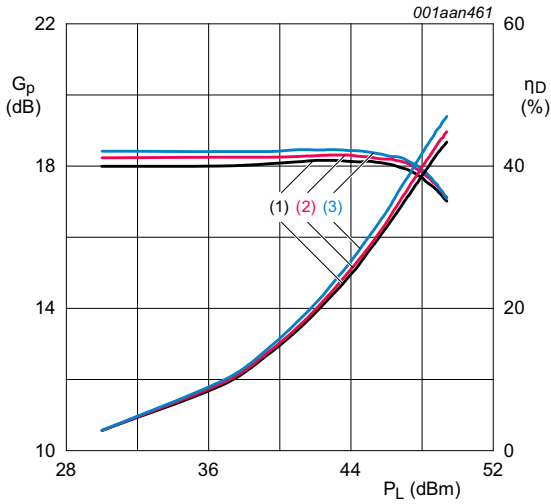
$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 1080\text{ mA}$ ;  $P_L = 160\text{ W (CW)}$ ,  $f = 1805\text{ MHz}$ ,

$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 350\text{ mA}$ ;  $P_L = 31.6\text{ W (IS-95)}$ ;  $P_L = 90\text{ W (pulsed CW, } \delta = 10\% \text{, } t_p = 100\text{ }\mu\text{s, per section)}$ ,  $f = 1495\text{ MHz}$ .

## 7.2 CW

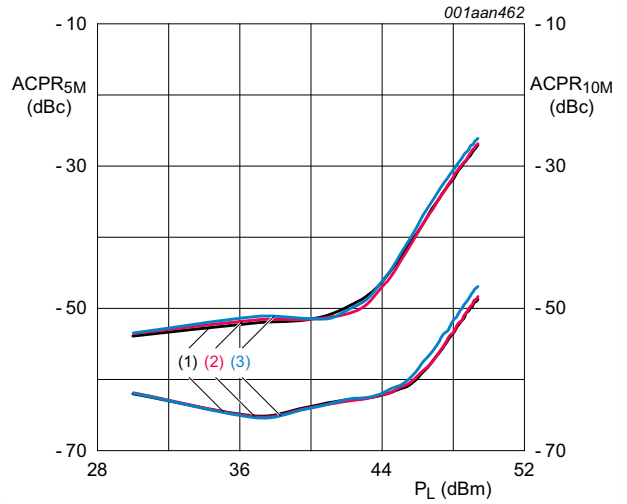


7.3 1-Carrier W-CDMA



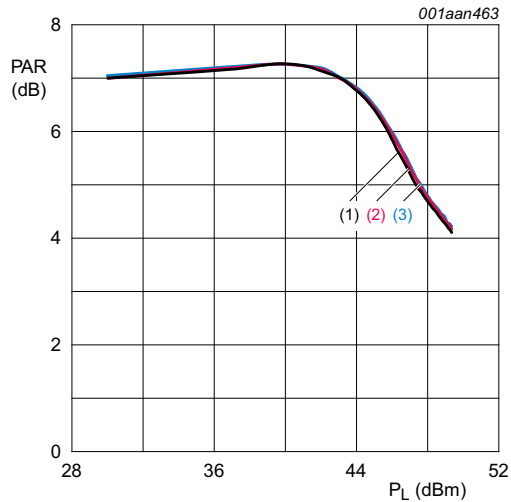
$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

**Fig 2. Power gain and drain efficiency as function of load power; typical values**



$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

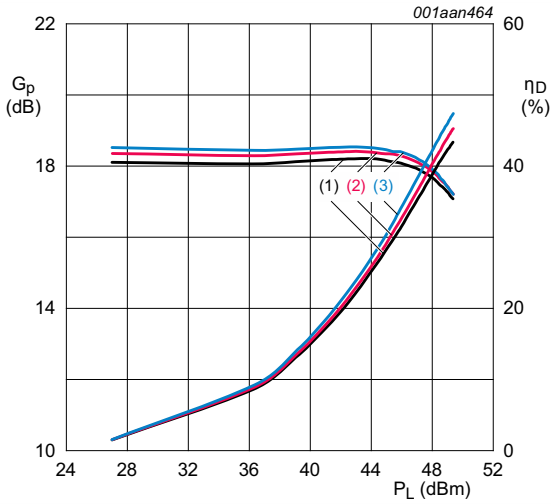
**Fig 3. Adjacent channel power ratio (5 MHz) and adjacent channel power ratio (10 MHz) as a function of load power; typical values**



$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

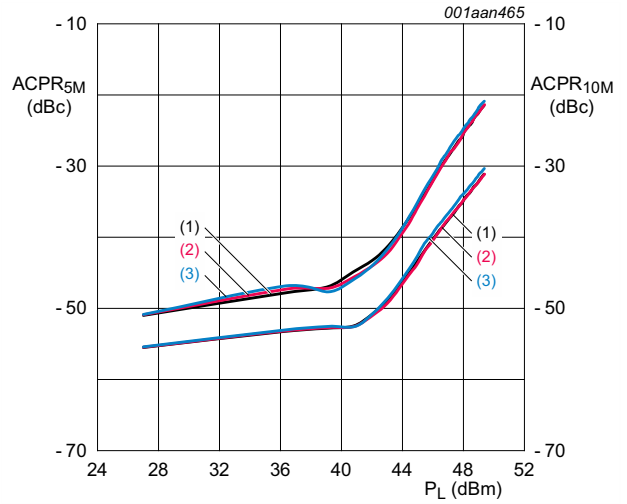
**Fig 4. Peak-to-average ratio as a function of load power; typical values**

7.4 2-Carrier W-CDMA 5 MHz



$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

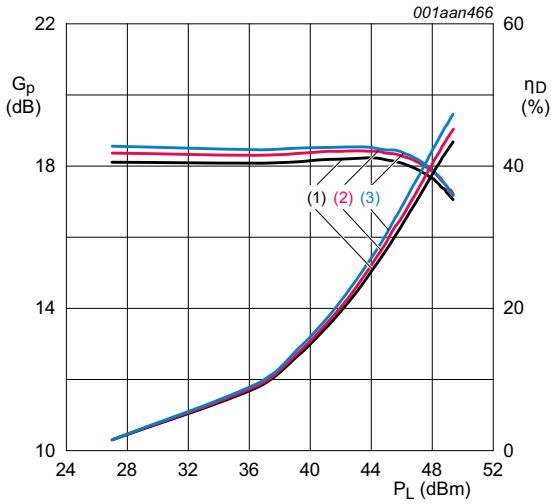
**Fig 5. Power gain and drain efficiency as function of load power; typical values**



$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

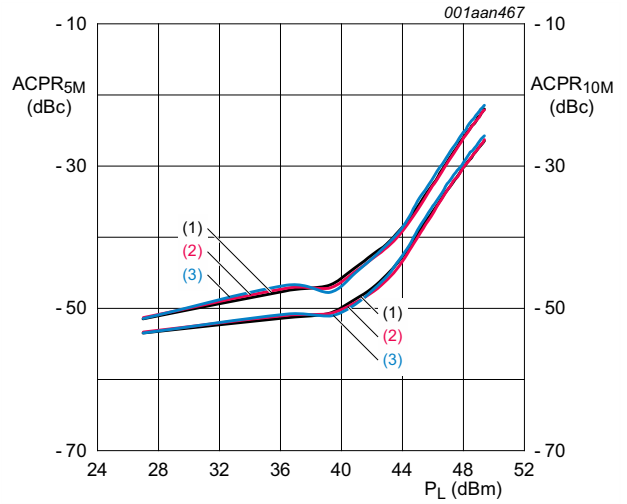
**Fig 6. Adjacent channel power ratio (5 MHz) and adjacent channel power ratio (10 MHz) as a function of load power; typical values**

7.5 2-Carrier W-CDMA 10 MHz



$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

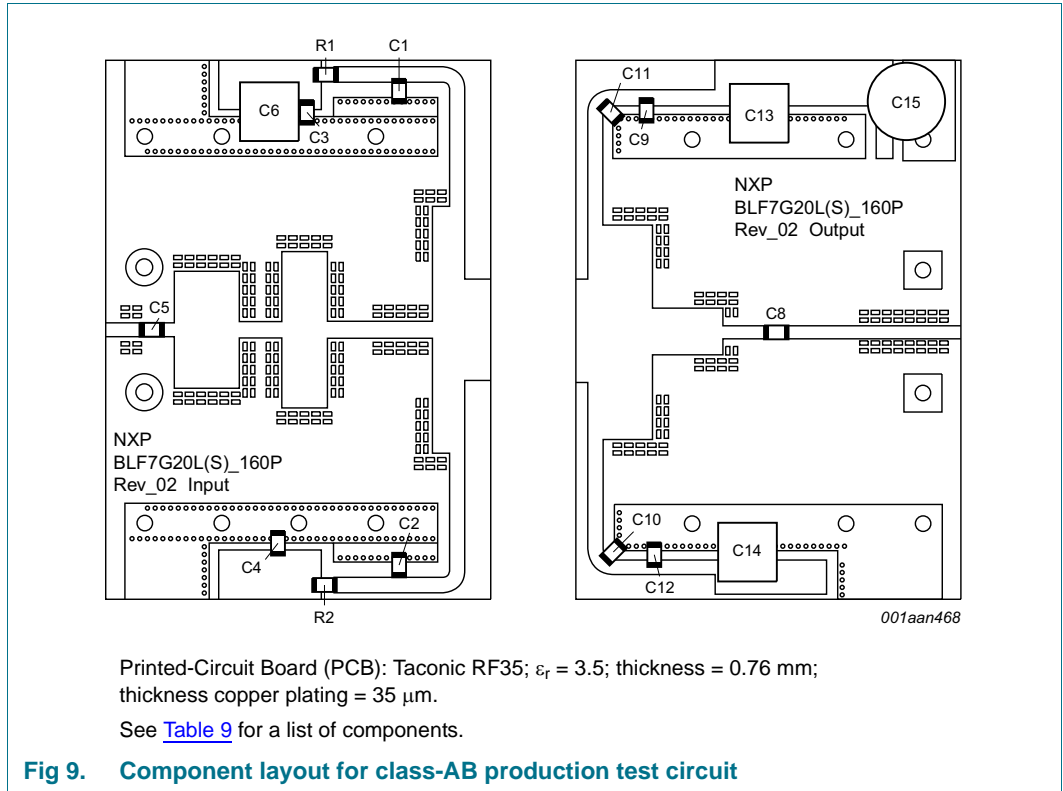
**Fig 7. Power gain and drain efficiency as function of load power; typical values**



$V_{DS} = 28\text{ V}; I_{Dq} = 1080\text{ mA}$ .  
 (1)  $f = 1930\text{ MHz}$   
 (2)  $f = 1960\text{ MHz}$   
 (3)  $f = 1990\text{ MHz}$

**Fig 8. Adjacent channel power ratio (5 MHz) and adjacent channel power ratio (10 MHz) as a function of load power; typical values**

**7.6 Test circuit**



**Table 9. List of components**

For test circuit see [Figure 9](#).

| Component           | Description                       | Value                    | Remarks      |
|---------------------|-----------------------------------|--------------------------|--------------|
| C1, C2, C5, C9, C10 | multilayer ceramic chip capacitor | 68 pF                    | [1]          |
| C3, C4, C11, C12    | multilayer ceramic chip capacitor | 820 pF                   | [2]          |
| C6, C13, C14        | multilayer ceramic chip capacitor | 10 $\mu\text{F}$         | [3]          |
| C8                  | multilayer ceramic chip capacitor | 10 pF                    | [1]          |
| C15                 | electrolytic capacitor            | 470 $\mu\text{F}$ ; 63 V |              |
| R1, R2              | SMD resistor                      | 12 $\Omega$              | Philips 1206 |

[1] American Technical Ceramics type 800B or capacitor of same quality.

[2] American Technical Ceramics type 100A or capacitor of same quality.

[3] TDK or capacitor of same quality.

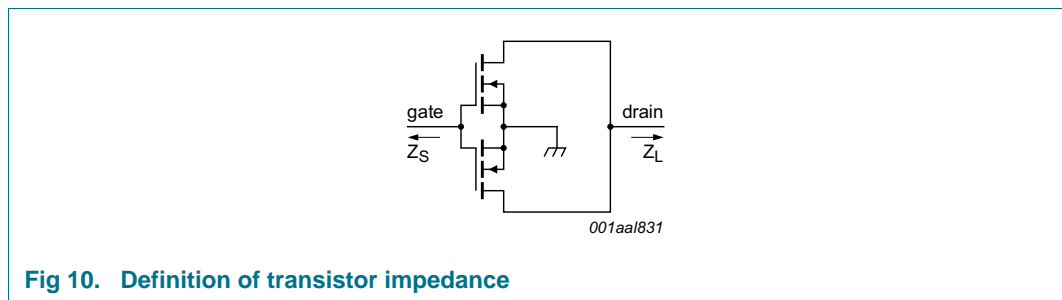


## 7.7 Impedance information

**Table 10. Typical impedance**

*Typical values valid for both section in parallel unless otherwise specified.*

| <b>f</b><br><b>MHz</b> | <b>Z<sub>S</sub></b><br><b>Ω</b> | <b>Z<sub>L</sub></b><br><b>Ω</b> |
|------------------------|----------------------------------|----------------------------------|
| 1750                   | 0.99 – j4.09                     | 2.32 – j2.35                     |
| 1805                   | 1.12 – j4.39                     | 2.20 – j2.20                     |
| 1840                   | 1.23 – j4.58                     | 2.08 – j2.14                     |
| 1880                   | 1.31 – j4.74                     | 1.94 – j2.12                     |
| 1930                   | 1.49 – j5.01                     | 1.76 – j2.15                     |
| 1960                   | 1.61 – j5.19                     | 1.66 – j2.20                     |
| 1990                   | 1.75 – j5.36                     | 1.56 – j2.26                     |
| 2020                   | 1.91 – j5.54                     | 1.48 – j2.34                     |
| 2050                   | 2.13 – j5.75                     | 1.4 – j2.42                      |



**Fig 10. Definition of transistor impedance**

8. Package outline

Flanged LDMOST ceramic package; 2 mounting holes; 4 leads

SOT1121A

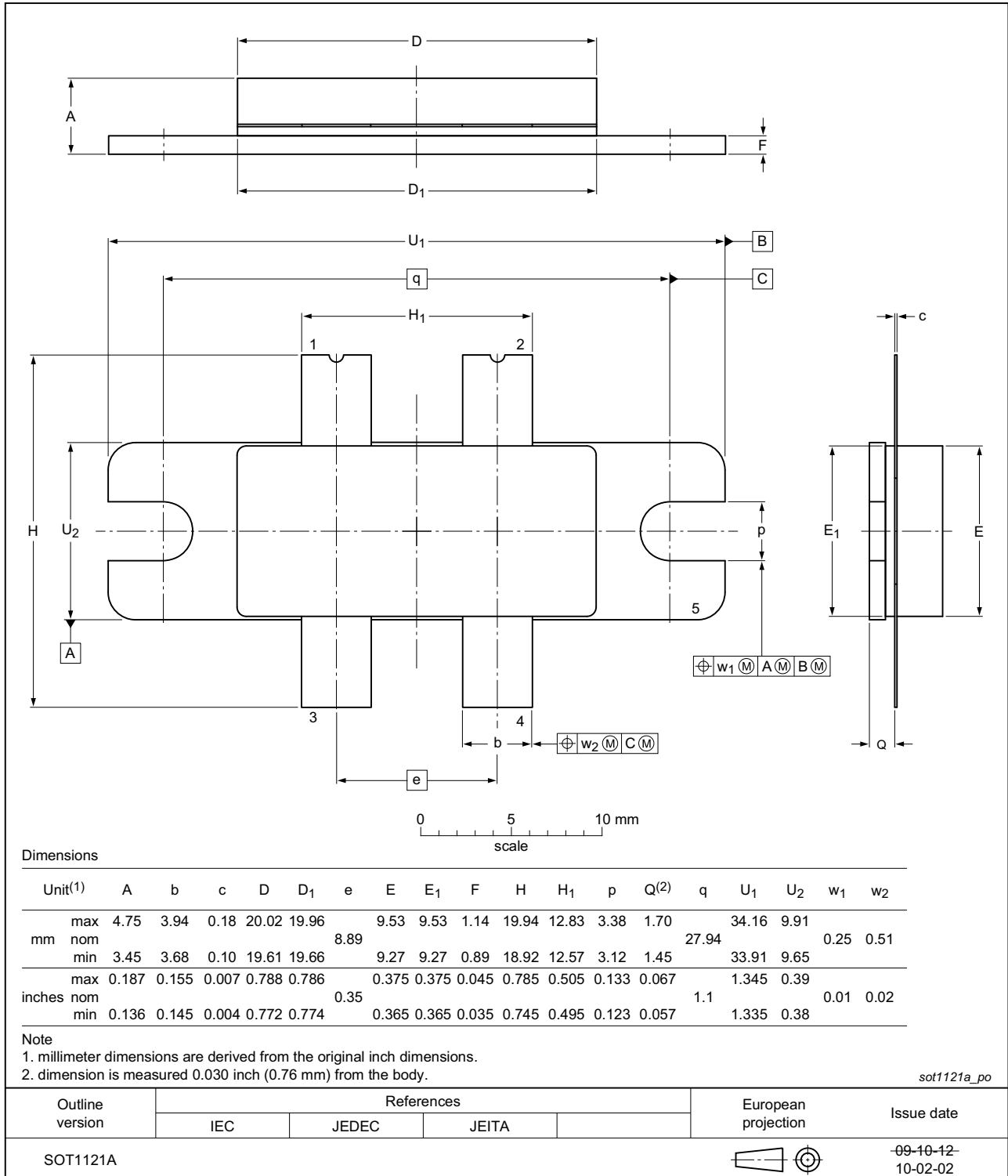


Fig 11. Package outline SOT1121A

Earless flanged ceramic package; 4 leads

SOT1121B

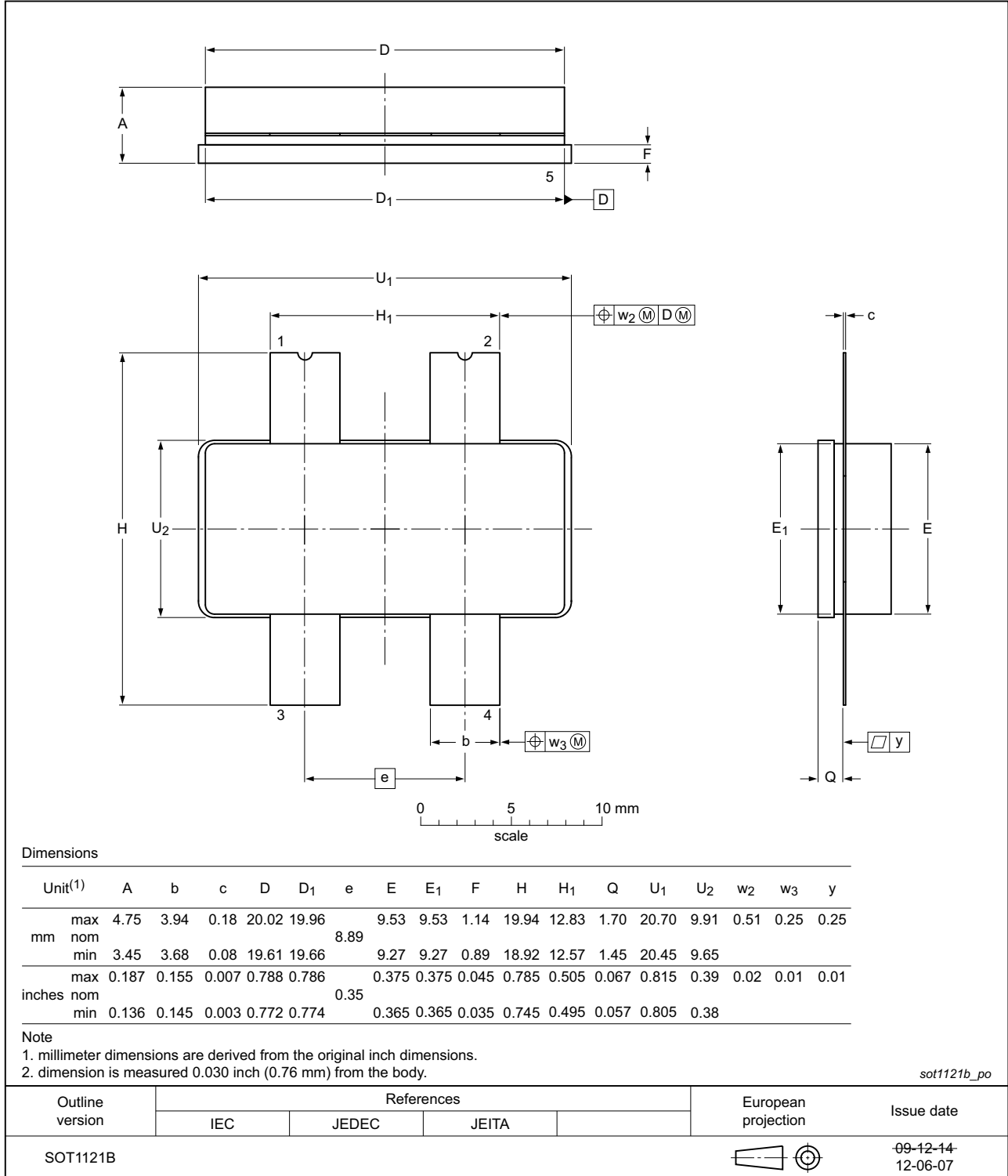


Fig 12. Package outline SOT1121B

## 9. Abbreviations

**Table 11. Abbreviations**

| Acronym | Description   |
|---------|---|
| 3GPP    | 3rd Generation Partnership Project                      |
| CCDF    | Complementary Cumulative Distribution Function          |
| CW      | Continuous Wave   |
| DPCH    | Dedicated Physical CHannel                              |
| ESD     | ElectroStatic Discharge                                 |
| IS-95   | Interim Standard 95                                     |
| LDMOS   | Laterally Diffused Metal Oxide Semiconductor            |
| LDMOST  | Laterally Diffused Metal Oxide Semiconductor Transistor |
| PAR     | Peak-to-Average Ratio                                   |
| PDPCH   | transmission Power of the Dedicated Physical CHannel    |
| SMD     | Surface Mounted Device                                  |
| VSWR    | Voltage Standing Wave Ratio                             |
| W-CDMA  | Wideband Code Division Multiple Access                  |

## 10. Revision history

**Table 12. Revision history**

| Document ID                   | Release date | Data sheet status    | Change notice | Supersedes   |
|-------------------------------|--------------|----------------------|---------------|--|
| BLF7G21L-160P_7G21LS-160P v.3 | 20140210     | Product data sheet   | -             | BLF7G21L-160P_7G21LS-160P v.2  |
| Modifications:                |              |                      |               |  |
|                               |              |                      |               | <ul style="list-style-type: none"> <li>• <a href="#">Section 1.1 on page 1</a>: description updated</li> <li>• <a href="#">Section 7.1 on page 4</a>: section updated</li> </ul> |
| BLF7G21L-160P_7G21LS-160P v.2 | 20111013     | Product data sheet   | -             | BLF7G21L-160P_7G21LS-160P v.1  |
| BLF7G21L-160P_7G21LS-160P v.1 | 20110401     | Objective data sheet | -             | -  |

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### 11.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition  |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet    | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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